

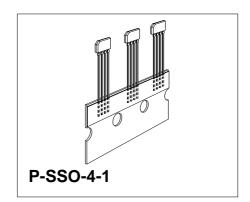
Dynamic Differential Hall Effect Sensor IC

TLE 4921-3U

Bipolar IC

Features

- Advanced performance
- High sensitivity
- Symmetrical thresholds
- · High piezo resistivity
- Reduced power consumption
- South and north pole pre-induction possible
- AC coupled
- Digital output signal
- Two-wire and three-wire configuration possible
- Large temperature range
- Large airgap
- Low cut-off frequency
- Protection against overvoltage
- · Protection against reversed polarity
- Output protection against electrical disturbances



Type	Marking	Ordering Code	Package
TLE 4921-3U	21C3U	Q67006-A9171	P-SSO-4-1

The differential Hall Effect sensor TLE 4921-3U provides a high sensitivity and a superior stability over temperature and symmetrical thresholds in order to achieve a stable duty cycle. TLE 4921-3U is particularly suitable for rotational speed detection and timing applications of ferromagnetic toothed wheels such as anti-lock braking systems, transmissions, crankshafts, etc. The integrated circuit (based on Hall effect) provides a digital signal output with frequency proportional to the speed of rotation. Unlike other rotational sensors differential Hall ICs are not influenced by radial vibration within the effective airgap of the sensor and require no external signal processing.



Pin Configuration

(view on branded side of component)

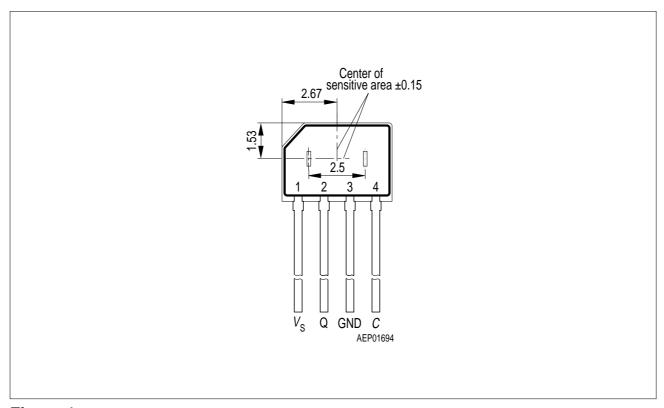


Figure 1

Pin Definitions and Functions

Pin No.	Symbol	Function
1	V_{S}	Supply voltage
2	Q	Output
3	GND	Ground
4	C	Capacitor



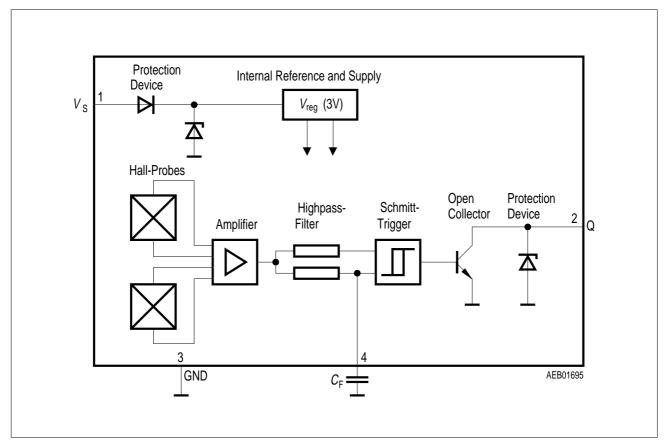


Figure 2 Block Diagram



Functional Description

The Differential Hall Sensor IC detects the motion and position of ferromagnetic and permanent magnet structures by measuring the differential flux density of the magnetic field. To detect ferromagnetic objects the magnetic field must be provided by a back biasing permanent magnet (**south or north** pole of the magnet attached to the rear unmarked side of the IC package).

Using an external capacitor the generated Hall voltage signal is slowly adjusted via an active high pass filter with a low cut-off frequency. This causes the output to switch into a biased mode after a time constant is elapsed. The time constant is determined by the external capacitor. Filtering avoids aging and temperature influence from Schmitt-trigger input and eliminates device and magnetic offset.

The TLE 4921-3U can be exploited to detect toothed wheel rotation in a rough environment. Jolts against the toothed wheel and ripple have no influence on the output signal.

Furthermore, the TLE 4921-3U can be operated in a two-wire as well as in a three-wire-configuration.

The output is logic compatible by high/low levels regarding on and off.

Circuit Description (see Figure 2)

The TLE 4921-3U is comprised of a supply voltage reference, a pair of Hall probes spaced at 2.5 mm, differential amplifier, filter for offset compensation, Schmitt trigger, and an open collector output.

The TLE 4921-3U was designed to have a wide range of application parameter variations. Differential fields up to \pm 80 mT can be detected without influence to the switching performance. The pre-induction field can either come from a magnetic south or north pole, whereby the field strength up to 500 mT or more will not influence the switching points. The improved temperature compensation enables a superior sensitivity and accuracy over the temperature range. Finally the optimized piezo compensation and the integrated dynamic offset compensation enable easy manufacturing and elimination of magnet offsets.

Protection is provided at the input/supply (pin 1) for overvoltage and reverse polarity and against overstress such as load dump, etc., in accordance with ISO-TR 7637 and DIN 40839. The output (pin 2) is protected against voltage peaks and electrical disturbances.

Data Sheet 4 2000-07-01



Absolute Maximum Ratings

 $T_{\rm i}$ = -40 to 150 °C

Parameter	Symbol	Limi	t Values	Unit	Remarks	
		min.	max.			
Supply voltage	V_{S}	- 35 ¹⁾	30	V	_	
Output voltage	V_{Q}	- 0.7	30	V	_	
Output current	I_{Q}	_	50	mA	_	
Output reverse current	$-I_{Q}$	_	50	mA	_	
Capacitor voltage	V_{C}	- 0.3	3	V	_	
Junction temperature Junction temperature Junction temperature Junction temperature	$egin{array}{c} T_{ m j} \ T_{ m j} \ T_{ m j} \ T_{ m j} \end{array}$	_ _ _ _	150 160 170 210	°C °C °C °C	5000 h 2500 h 1000 h 40 h	
Storage temperature	T_{S}	- 40	150	°C	_	
Thermal resistance P-SSO-4-1	R_{thJA}	_	190	K/W	_	
Current through input- protection device Current through output- protection device	I_{SZ} I_{QZ}	_	200	mA mA	t < 2 ms; v = 0.1 t < 2 ms; v = 0.1	

Electro Magnetic Compatibility

ref. DIN 40839 part 1; test circuit 1

Testpulse 1	V_{LD}	– 100		V	$t_{\rm d} = 2 \text{ ms}$
Testpulse 2	$V_{LD}^{}$		100	V	$t_{\rm d} = 0.05 \rm ms$
Testpulse 3a	V_{LD}	– 150		V	$t_{\rm d} = 0.1 \; \mu s$
Testpulse 3b	V_{LD}		100	V	$t_{\rm d} = 0.1 \; \mu {\rm s}$
Testpulse 4	V_{LD}	-7		V	$t_{\rm d} \leq 20 \text{ s}$
Testpulse 5	V_{LD}		120	V	$t_{\rm d} = 400 \text{ ms};$
					$R_{P} = 400 \ \Omega$

¹⁾ Reverse current < 10 mA

Note: Stresses above those listed here may cause permanent damage to the device. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



Operating Range

Parameter	Symbol	Limi	it Values	Unit	Remarks	
		min.	max.			
Supply voltage	V_{S}	4.5	24	V	_	
Junction temperature	T_{j}	- 40	170	°C	_	
Pre-induction	B_0	- 500	500	mT	at Hall probe; independent of magnet orientation	
Differential induction	ΔB	- 80	80	mT	_	

Note: In the operating range the functions given in the circuit description are fulfilled.

AC/DC Characteristics

Parameter	Symbol	Limit Values			Unit	Test Condition	Test
		min.	typ.	max.			Circuit
Supply current	I_{S}	4.7	6.1	8.0	mA	$V_{\rm Q}$ = high $I_{\rm O}$ = 0 mA	1
		5.1	6.7	8.8	mA	$V_{\rm Q}$ = low $I_{\rm Q}$ = 40 mA	1
Output saturation voltage	V_{QSat}	_	0.25	0.6	V	$I_{\rm Q}$ = 40 mA	1
Output leakage current	I_{QL}	_	_	10	μΑ	V _Q = 24 V	1
Center of switching points: $(\Delta B_{\text{OP}} + \Delta B_{\text{RP}}) / 2$	$\Delta \boldsymbol{B}_{m}$	– 1	0	1	mT	$-20 \text{ mT} < \Delta B < 20 \text{ mT}^{-1)(2)}$ f = 200 Hz	2
Operate point	ΔB_{OP}	_	_	0	mT	f = 200 Hz, ΔB = 20 mT	2
Release point	ΔB_{RP}	0	_	_	mT	f = 200 Hz, ΔB = 20 mT	2
Hysteresis	ΔB_{Hy}	0.5	1.5	2.5	mT	f = 200 Hz, ΔB = 20 mT	2
Overvoltage							
protection at supply voltage at output	$V_{SZ} \ V_{QZ}$	27 27	_	35 35	V	$I_{\rm S}$ = 16 mA $I_{\rm S}$ = 16 mA	1
Output rise time	$t_{\rm r}$	_	_	0.5	μs	$I_{\rm Q}$ = 40 mA $C_{\rm L}$ = 10 pF	1



AC/DC Characteristics (cont'd)

Parameter	Symbol	Limit Values			Unit	Test Condition	Test
		min.	typ.	max.			Circuit
Output fall time	t_{f}	_	_	0.5	μs	$I_{\rm Q}$ = 40 mA $C_{\rm L}$ = 10 pF	1
Delay time ³⁾	t_{dop} t_{drp} t_{dop} - t_{drp}	_ _ _	_ _ 0	25 10 15	μs μs μs	f = 10 kHz ΔB = 5 mT	2
Filter input resistance	R_{C}	32	40	48	kΩ	25 °C ± 2 °C	1
Filter sensitivity to ΔB	$S_{\mathbb{C}}$	_	- 4	_	mV/ mT	_	1
Filter bias voltage	V_{C}	0.8	_	2.2	V	$\Delta B = 0$	1
Frequency	f	4)	_	20000	Hz	$\Delta B = 5 \text{ mT}$	2
Resistivity against mechanical stress (piezo)	$\Delta B_{m} \ \Delta B_{Hy}$	- 0.1 - 0.1	_	0.1 0.1	mT mT	F = 2 N	2 ⁵⁾

Leakage currents at pin 4 should be avoided. The bias shift of $B_{\rm m}$ caused by a leakage current $I_{\rm L}$ can be calculated by: $\Delta B_{\rm m} = \frac{I_{\rm L} \times R_{\rm C}({\rm T})}{S_{\rm C}({\rm T})}$.

Note: The listed characteristics are ensured over the operating range of the integrated circuit. Typical characteristics specify mean values expected over the production spread. If not otherwise specified, typical characteristics apply at $T_j = 25^{\circ}\text{C}$ and the given supply voltage.

For higher ΔB the values may exceed the limits like following $|\Delta B_{\rm m}| < |0.05 \times \Delta B|$

³⁾ For definition see page 16.

Depends on filter capacitor $C_{\rm F}$. The cut-off frequency is given by $f=\frac{1}{2\pi\times R_{\rm C}\times C_{\rm F}}$. The switching points are guaranteed over the whole frequency range, but amplitude modification and phase shift due to the 1st order highpass filter have to be taken into account.

⁵⁾ See page 17.



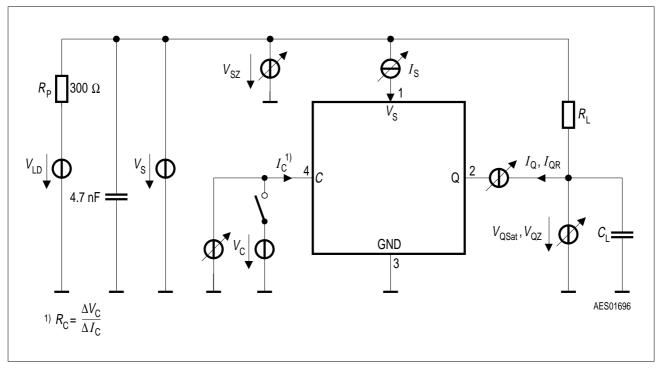


Figure 3 Test Circuit 1

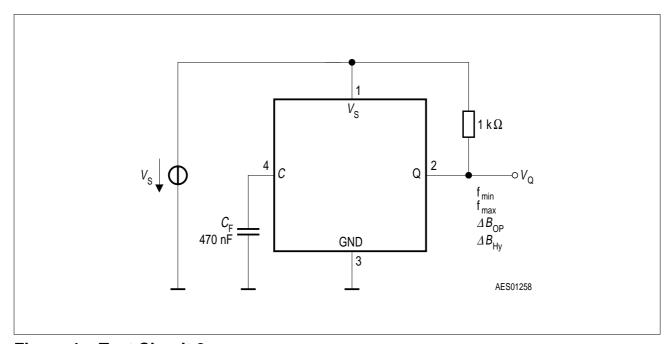


Figure 4 Test Circuit 2



Application Configurations

Two possible applications are shown in **Figure 7 and 8** (Toothed and Magnet Wheel). The difference between two-wire and three-wire application is shown in **Figure 9**.

Gear Tooth Sensing

In the case of ferromagnetic toothed wheel application the IC has to be biased by the south or north pole of a permanent magnet (e.g. $SmCO_5$ (Vacuumschmelze VX145) with the dimensions 8 mm \times 5 mm \times 3 mm) which should cover both Hall probes.

The maximum air gap depends on

- the magnetic field strength (magnet used; pre-induction) and
- the toothed wheel that is used (dimensions, material, etc.; resulting differential field)

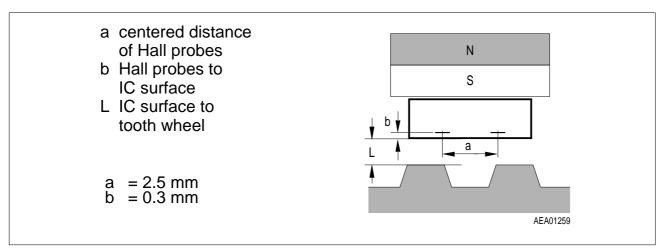


Figure 5 Sensor Spacing

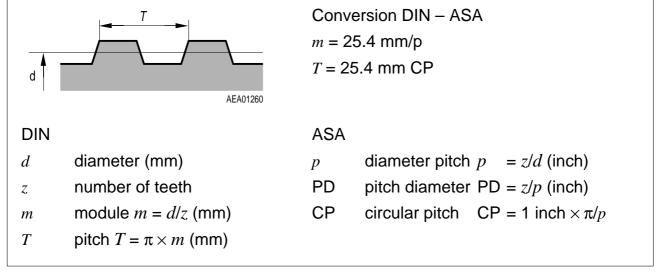


Figure 6 Toothed Wheel Dimensions



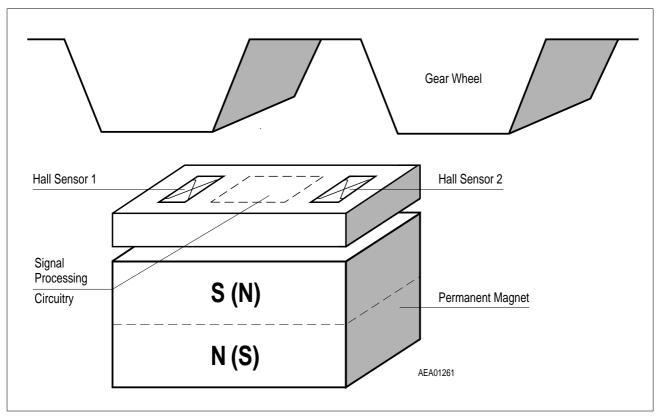


Figure 7 TLE 4921-3U, with Ferromagnetic Toothed Wheel

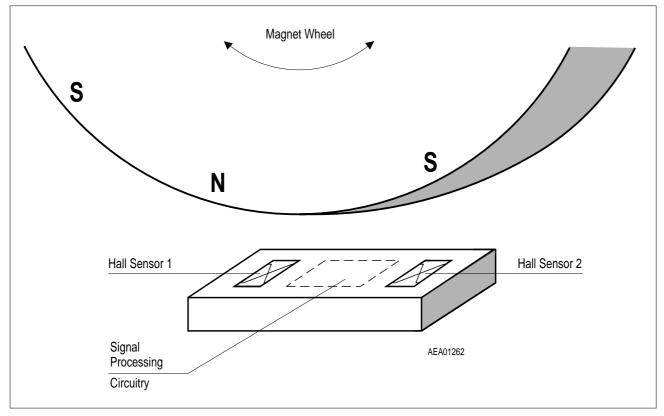


Figure 8 TLE 4921-3U, with Magnet Wheel



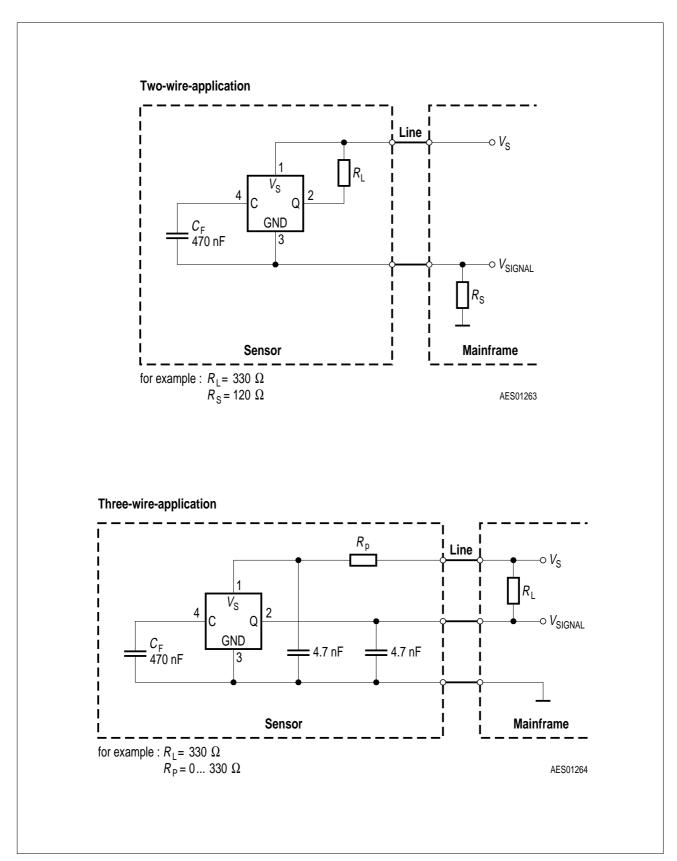


Figure 9 Application Circuits



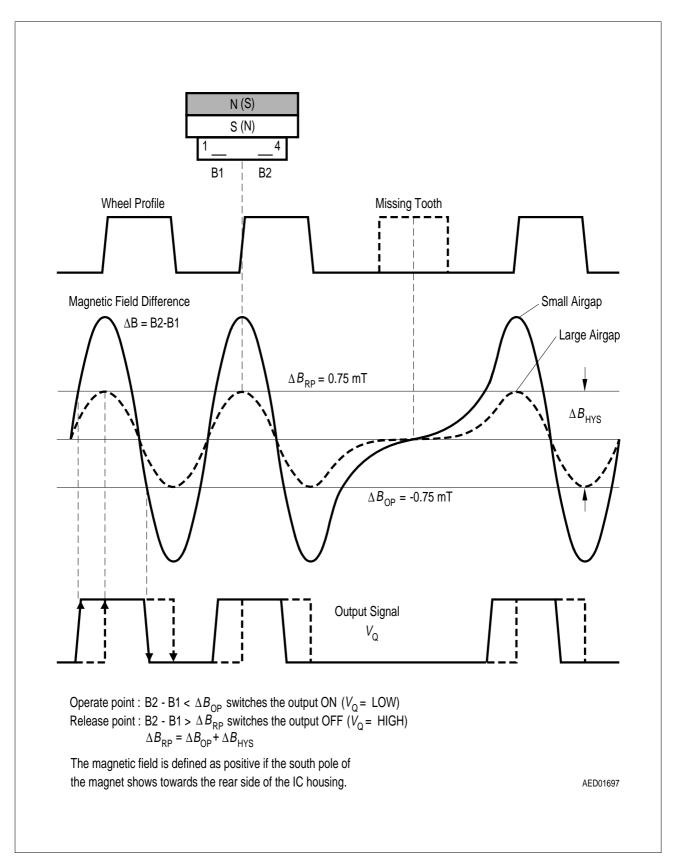
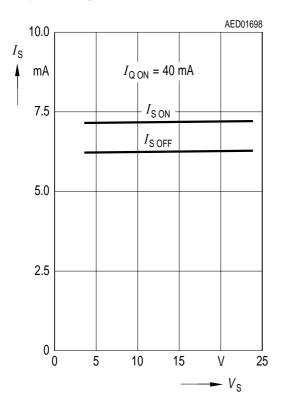


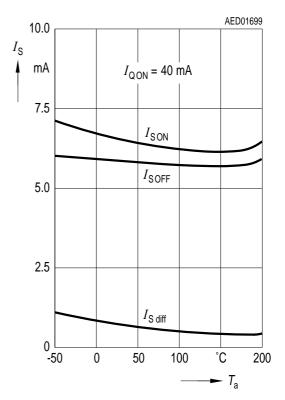
Figure 10 System Operation



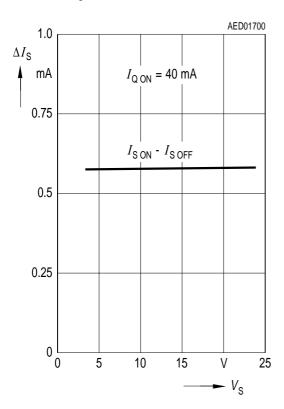
Quiescent Current versus Supply Voltage



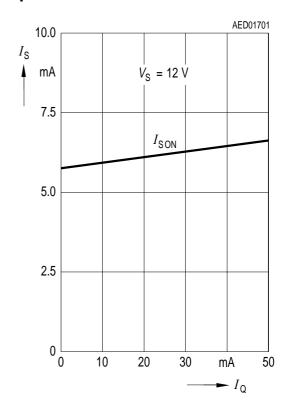
Quiescent Current versus Temperature



Quiescent Current Difference versus Temperature



Quiescent Current versus Output Current

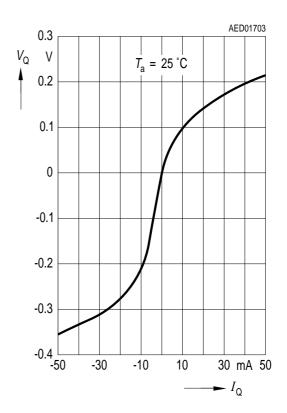




Saturation Voltage versus Temperature

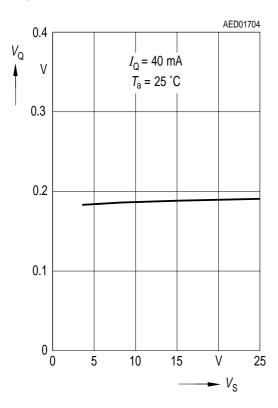
AED01702 0.4 V_{Q} $V_{\rm S} = 4.5 \, \rm V$ ٧ $I_{\rm Q} = 50 \, {\rm mA}$ 0.3 0.2 0.1 0 -50 0 50 100 °C 200

Saturation Voltage versus Output Current

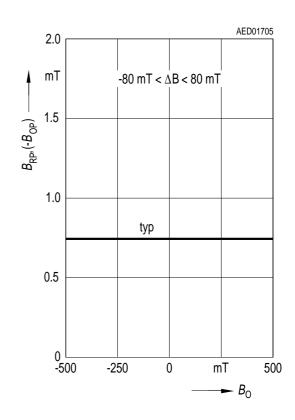


Saturation Voltage versus Supply Voltage

- T_a

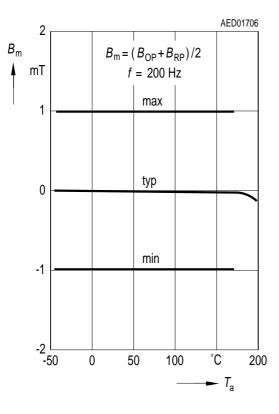


Switching Points versus Preinduction

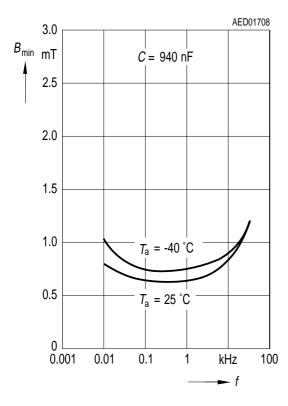




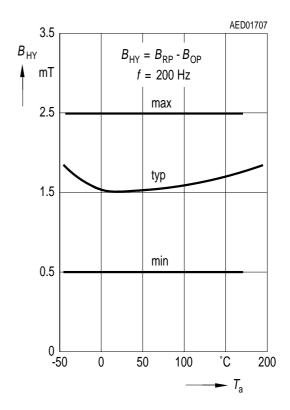
Switching Induction versus Temperature



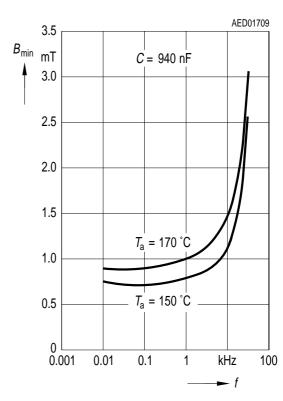
Minimum Switching Field versus Frequency



Hysteresis versus Temperature

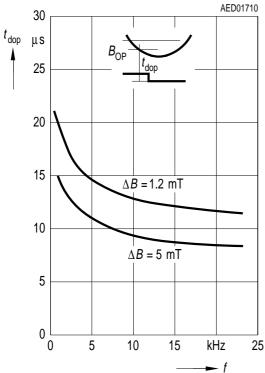


Minimum Switching Field versus Frequency

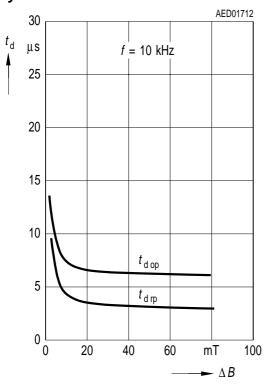




Delay Time¹⁾ between Switching Threshold ΔB and Falling Edge of $V_{\rm Q}$ at $T_{\rm j}$ = 25 °C

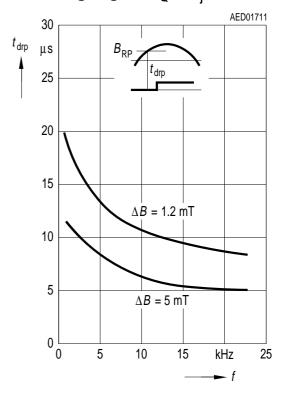


Delay Time¹⁾ versus Differential Field

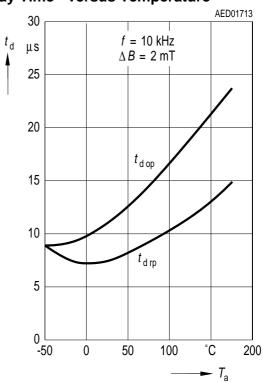


Switching points related to initial measurement $@\Delta B = 2 \text{ mT}, f = 200 \text{ Hz}$

Delay Time¹⁾ between Switching Threshold ΔB and Rising Edge of $V_{\rm Q}$ at $T_{\rm j}$ = 25 °C

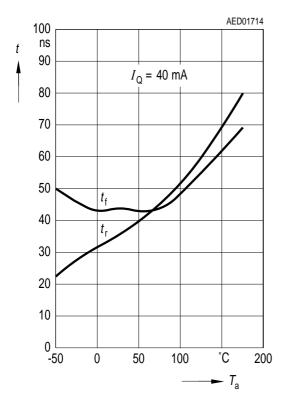


Delay Time¹⁾ versus Temperature

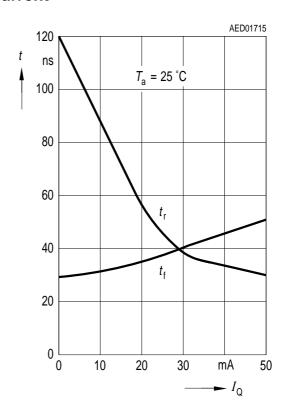




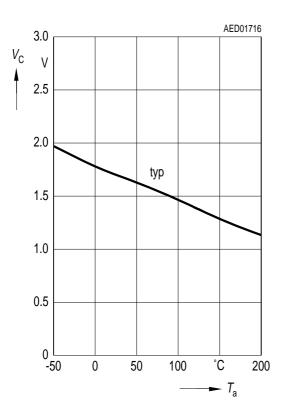
Rise and Fall Time versus Temperature



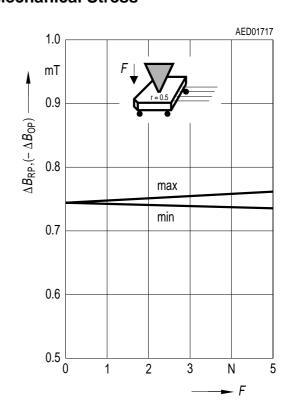
Rise and Fall Time versus Output Current



Capacitor Voltage versus Temperature

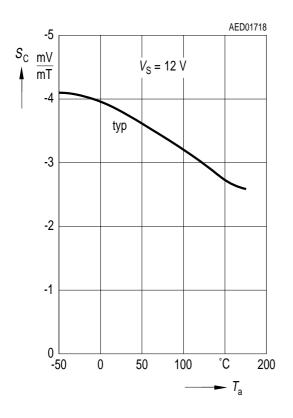


Switching Thresholds versus Mechanical Stress

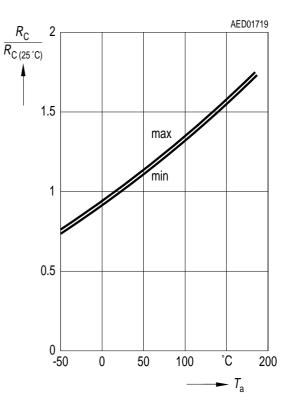




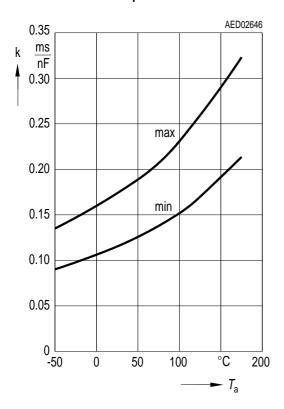
Filter Sensitivity versus Temperature



Filter Input Resistance versus Temperature

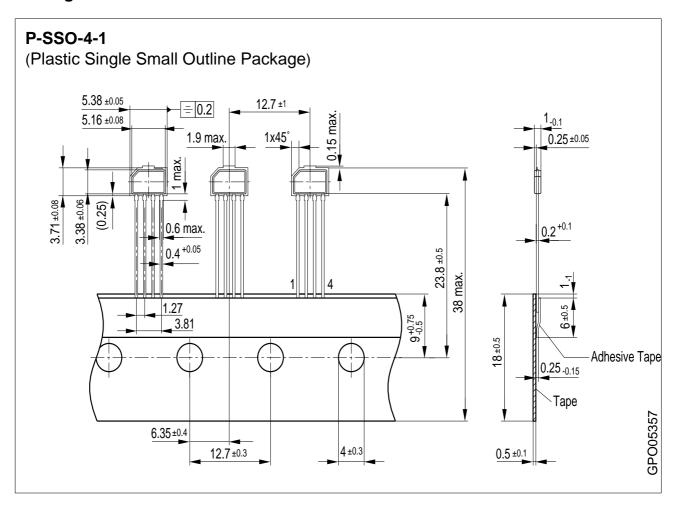


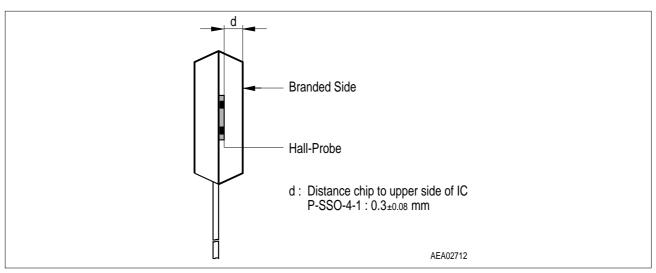
Delay Time for Power on ($V_{\rm S}$ Switching from 0 V to 4.5 V) $t_{\rm pon}$ versus Temp.





Package Outlines





Sorts of Packing

Package outlines for tubes, trays etc. are contained in our Data Book "Package Information".

Dimensions in mm

This datasheet has been download from:

www.datasheetcatalog.com

Datasheets for electronics components.